Reliability and Test Condition

Item	Performance	Test Condition
Electrical Performance Test		
Inductance	Refer to standard electrical characteristics list	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter
DCR		CH16502,Agilent33420A Micro-Ohm Meter
Saturation Current (Isat)	Approximately △L30%.	Saturation DC Current (Isat) will cause L0 to drop △L(%)
Heat Rated Current (Irms)	Approximately △T40℃	Heat Rated Current (Irms) will cause the coil temperature rise △T(℃). 1.Applied the allowed DC current. 2.Temperature measured by digital surface thermometer
Operating Temperature	-40℃~+125℃ (Including self - temperature rise)	
Storage Temperature	1.-10~+40℃,50~60%RH (Product without taping) 2.-40~+125℃ (on board)	
Reliability Test		
Life Test	Appearance：No damage Inductance：within±10% of initial value Q：Shall not exceed the specification value RDC：within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature： 125±2℃(Inductor) Applied current：rated current Duration：1000±12hrs Measured at room temperature after placing for 24±2 hrs
Load Humidity		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Humidity：85±2% R.H Temperature：85℃±2℃ Duration：1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs
Moisture Resistance		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) 1. Baked at50℃ for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2℃ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25℃ in 2.5hrs. 3. Raise temperature to 65±2℃ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25℃ in 2.5hrs, keep at 25℃ for 2 hrs then keep at -10℃ for 3 hrs 4. Keep at 25℃ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.
Thermal shock		Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1：-40±2℃ 30±5min Step2：25±2℃ ≦0.5min Step3：125±2℃ 30±5min Number of cycles： 500 Measured at room temperature after placing for 24±2 hrs
Vibration		Oscillation Frequency: 10～2K～10Hz for 20 minutes Equipment： Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations)。

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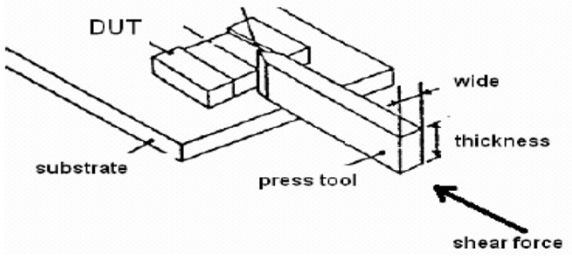
<table>
<tr><th>Item</th><th>Performance</th><th>Test Condition</th></tr>
<tr><td colspan="3">Reliability Test</td></tr>
<tr><td>Shock</td><td rowspan="2">Appearance：No damage.
Inductance：within±10% of initial value
Q：Shall not exceed the specification value
RDC：within ±15% of initial value and shall not exceed the specification value</td><td>
<table>
<tr><th rowspan="2">Type</th><th>Peak value</th><th>Normal</th><th rowspan="2">Wave form</th><th>Velocity</th></tr>
<tr><th>(g's)</th><th>duration (D) (ms)</th><th>change (Vi)ft/sec</th></tr>
<tr><td>SMD</td><td>50</td><td>11</td><td>Half-sine</td><td>11.3</td></tr>
<tr><td>Lead</td><td>50</td><td>11</td><td>Half-sine</td><td>11.3</td></tr>
</table>
</td></tr>
<tr><td>Bending</td><td>Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm
<0805 inch(2012mm):40x100x0.8mm
Bending depth:
>=0805 inch(2012mm):1.2mm
<0805 inch(2012mm):0.8mm
duration of 10 sec</td></tr>
<tr><td>Soderability</td><td>More than 95% of the terminal electrode should be covered with solder</td><td>Preheat: 150℃,60sec
Solder: Sn96.5% Ag3% Cu0.5%
Temperature: 245±5℃
Flux for lead free: Rosin. 9.5%
Dip time: 4±1sec
Depth: completely cover the termination</td></tr>
<tr><td>Resistance to Soldering Heat</td><td rowspan="2">Appearance：No damage.
Inductance：within±10% of initial value
Q：Shall not exceed the specification value
RDC：within ±15% of initial value and shall not exceed the specification value</td><td>Number of heat cycles: 1
<table>
<tr><th>Temperature (°C)</th><th>Time (s)</th><th>Temperature ramp/immersion and emersion rate</th></tr>
<tr><td>260 ±5 (solder temp)</td><td>10 ±1</td><td>25mm/s ±6 mm/s</td></tr>
</table>
</td></tr>
<tr><td>Terminal Strength</td><td>Preconditioning:Run through IR reflow for 2 times (IPC/JEDEC J-STD-020D Classification Reflow Profiles)
With the component mounted on a PCB with the device to be tested, apply a force (>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.
 
</td></tr>
</table>

Note : When there are questions concerning measurement result measurement shall be made after 48 ± 2 hours
Of recovery under the standard condition.

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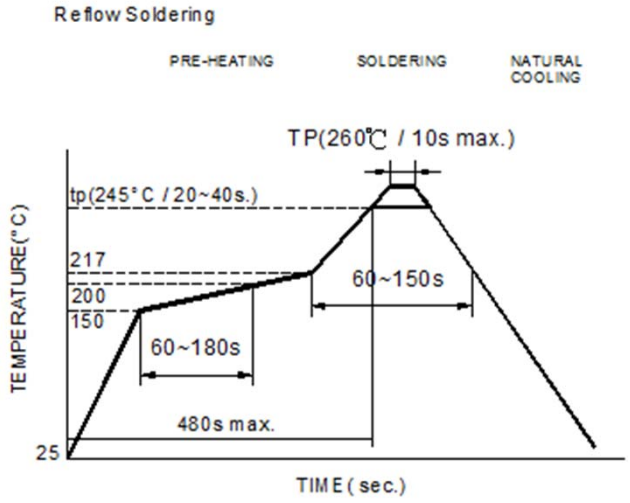
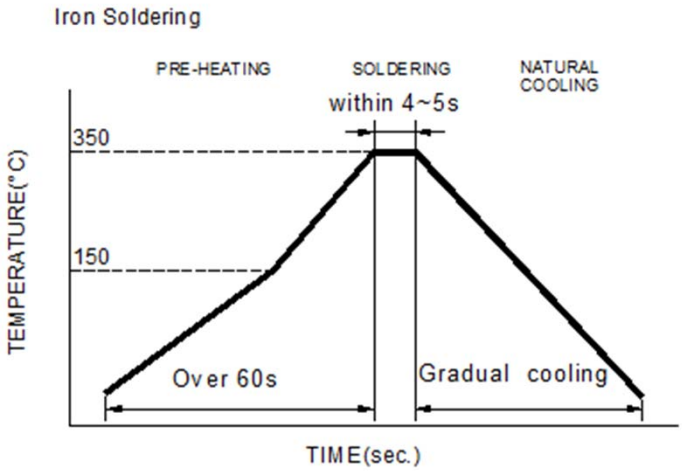
Reliability Test		
Soldering	Mildly activated rosin fluxes are preferred. JANTEK terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.	
Lead Free Solder re-flow:	Recommended temperature profiles for re-flow soldering in Figure 1.	
Soldering Iron(Figure 2):	Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. Note： ・Preheat circuit and products to 150℃ ・Never contact the ceramic with the iron tip ・Use a 20 watt soldering iron with tip diameter of 1.0mm ・355℃ tip temperature (max) ・1.0mm tip diameter (max) ・Limit soldering time to 4~5 sec	



Reflow times: 3 times max.

Fig1



Iron Soldering times: 1 times max.

Fig.2